## Notice of References Cited Application/Control No. 10/711,916 Examiner Ryan C. Jager Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,198,340	03-2001	Ting et al.	327/536
*	В	US-6,100,557	08-2000	Hung et al.	257/299
*	С	US-5,909,141	06-1999	Tomishima, Shigeki	327/536
*	D	US-6,456,154	09-2002	Sugimura, Naoaki	327/537
	E	US-			
	F	US-	·		
	G	US-		*	
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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